

<b>Notice of References Cited</b>		Application/Control No. 10/584,712	Applicant(s)/Patent Under Reexamination KAWAGOE ET AL.	
		Examiner DEVANG PATEL	Art Unit 1793	Page 1 of 1

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*	A	US-3,883,386	05-1975	Garbini et al.	156/498
*	B	US-5,674,542	10-1997	Focke et al.	425/297
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	E	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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